

Semicustom

CMOS

Standard Cell

CS201 Series

■ DESCRIPTION

The CS201 series of 65 nm standard cells is a line of CMOS ASICs that satisfy demands for lower power consumption and higher integration. These cells offer the minimum level of leakage current in the semiconductor industry, and are able to implement a mixture of core transistors with three different threshold voltages, as appropriate for the applications ranging from handheld terminals to digital audiovisual equipment.

The integration level in this series is twice the previous series with lower power consumption.

■ FEATURES

- Technology : 65 nm Si gate CMOS
6 to 12 layers of metal wiring.
Three different types of core transistors (low leak, standard and high speed) can be used on the same chip.
- Power supply voltage : Supports a wide range from + 0.9 V to + 1.3 V
- Operation junction temperature : - 40 °C to + 125 °C (standard)
- Gate delay time : 11 ps (1.2 V, Inverter, F/O = 1)
- Gate power consumption : 1.77 nW/gate (operating condition: 1.2 V, operating rate 0.5, 1 MHz)
- Reduced chip size achieved by creating the wire bonding pads within the I/O macro regions.
- Support various cell sets (from low power versions to high speed versions)
- Compiled cell (RAM, ROM, others)
- Support low-consumption technology “CoolAdjust™”*
- Support ultra high speed (up to 10 Gbps) interface macros
- Special interfaces (LVDS, SSTL, others)
- Short-term development using a physical prototyping tool
- One pass design using a physical synthesis tool
- Hierarchical design environment for supporting large-scale circuits
- Support Signal Integrity, EMI noise reduction
- Support static timing sign-off
- Improve timing convergence by using Statistical Static Timing Analysis (SSTA)
- Design For Manufacturing (DFM) enables stable product-supply and reduced variation
- Optimum package range : FBGA, PBGA, TEBGA, FC-BGA

*: “CoolAdjust” is low power solution presented by Socionext America Inc.

■ MACRO LIBRARIES

1. Logic cells (about 400 types)

Library sets having three different threshold voltages of core transistors.

- Adder
- AND-OR Inverter
- Delay Buffer
- Inverter
- NOR
- OR-AND Inverter
- Multiplexer
- Others
- AND
- Buffer
- ENOR
- Latch
- OR
- SCAN Flip flop
- AND-OR
- Clock Buffer
- EOR
- NAND
- OR-AND
- Non-SCAN Flip Flop

2. IP macros

The following macros will be made available for the CS201 series.

CPU/DSP	ARM™* cores(ARM7/ARM9/ARM11)
Mixed signal macro	ADC, DAC, OPAMP, others
Compiled macro	SRAM (1 Port, 2 Port), ROM, product sum calculators
Large capacity memory	1T-SRAM-Q
PLL	Analog PLL

* : ARM is the trademark of ARM Limited in the EU and other countries.

3. Special I/O interface macro

Interface macro (PHY)	LVDS, SSTL2, SSTL18, PCI, I ² C, others
Interface macro (controller)	USB2.0 Device/host, Serial ATA, PCI-Express, DDR2, HDMI, others

■ COMPILED CELL

Compiled cells are macro cells that can be automatically generated by specifying the bit/word configuration. The following compiled cells are available for the CS201 series (Note that the bit/word ranges for each macro vary depending on the column type).

1. Clock synchronous single-port RAM (1 address : 1 read/write)

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
2	16 to 160K	16 to 1K	1 to 160
4	32 to 640K	32 to 8K	1 to 80
8	64 to 640K	64 to 16K	1 to 40

2. Clock synchronous single-port RAM [High capacity type] (1 address : 1 read/write)

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
16	64K to 9M	8K to 64K	8 to 144

3. Clock synchronous dual port RAM (2 addresses : 2 read/write)

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
2	32 to 72K	16 to 512	2 to 144
4	64 to 72K	32 to 1K	2 to 72
8	128 to 72K	64 to 2K	2 to 36
16	256 to 72K	128 to 4K	2 to 18

4. Clock synchronous 2 port RAM (2 addresses : 1 read,1 write)

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
2	32 to 72K	16 to 512	2 to 144

5. Clock synchronous 2 port RAM [Reduced version] (2 addresses : 1 read,1 write)

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
2	64 to 72K	32 to 512	2 to 144
4	128 to 72K	64 to 1K	2 to 72
8	256 to 72K	128 to 2K	2 to 36

6. Clock synchronous ROM

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
16	256 to 1M	128 to 8K	2 to 128
64	1K to 1M	512 to 32K	2 to 32

7. Clock synchronous register file (2 addresses : 1 read,1 write)

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
1	16 to 18K	8 to 128	2 to 144

8. Clock synchronous register file (4 addresses : 2 read,2 write)

Column type	Memory capacity (bit)	Word range (word)	Bit range (bit)
1	16 to 18K	8 to 128	2 to 144

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■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rating		Unit	Remarks
		Min	Max		
Power supply voltage*1	V _{DD}	- 0.5	+ 1.8	V	*2
		- 0.5	+ 2.5		*3
		- 0.5	+ 3.6		*4
		- 0.5	+ 4.6		*5
Input voltage*1	V _I	- 0.5	V _{DD} + 0.5 (≤ 2.5 V)	V	*3
		- 0.5	V _{DD} + 0.5 (≤ 3.6 V)		*4
		- 0.5	V _{DD} + 0.5 (≤ 4.6 V)		*5
Output voltage*1	V _O	- 0.5	V _{DD} + 0.5 (≤ 2.5 V)	V	*3
		- 0.5	V _{DD} + 0.5 (≤ 3.6 V)		*4
		- 0.5	V _{DD} + 0.5 (≤ 4.6 V)		*5
Storage temperature	T _{STG}	- 55	+ 125	°C	
Operation junction temperature	T _j	- 40	+ 125	°C	
Output current*6	I _O	—	16	mA	
Power supply pin current*7	I _D	—	40	mA	

*1 : V_{SS} = 0 V

*2 : Internal gates

*3 : 1.8 V interface on dual-power supply system

*4 : 2.5 V interface on dual-power supply system

*5 : 3.3 V interface on dual-power supply system

*6 : The output current varies depending on the number of wiring layers in the chip and the wiring configuration of the I/O cells. Contact the sales representative for details.

*7 : The power supply pin current depends on the type of chip frame. Contact the sales representative for details.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

• Dual power supply

($V_{DDE} = 3.3\text{ V} \pm 0.3\text{ V}$, $V_{DDI} = 1.0\text{ V} \pm 0.1\text{ V}/V_{DDI} = 1.2\text{ V} \pm 0.1\text{ V}$)

($V_{SS} = 0\text{ V}$)

Parameter		Symbol	Value			Unit
			Min	Typ	Max	
Power supply voltage		V_{DDE}	3.0	3.3	3.6	V
		V_{DDI}	0.9	1.0	1.1	V
				1.1	1.2	1.3
“H” level input voltage	3.3 V CMOS Normal	V_{IH}	2.0	—	$V_{DDE} + 0.3$	V
	3.3 V CMOS Schmitt		2.1	—	$V_{DDE} + 0.3$	V
“L” level input voltage	3.3 V CMOS Normal	V_{IL}	- 0.3	—	+ 0.8	V
	3.3 V CMOS Schmitt		- 0.3	—	+ 0.7	V
Schmitt hysteresis voltage		V_H	0.2	—	1.4	V
Operation junction temperature		T_j	- 40	—	+ 125	°C

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges.

Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

Note: For LVCMOS 1.8 V and 2.5 V versions, contact the sales representative.

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■ ELECTRICAL CHARACTERISTICS

• Dual power supply

($V_{DDE} = 3.3\text{ V} \pm 0.3\text{ V}$, $V_{DDI} = 1.0\text{ V} \pm 0.1\text{ V}/V_{DDI} = 1.2\text{ V} \pm 0.1\text{ V}$)

($V_{DDE} = 3.3\text{ V} \pm 0.3\text{ V}$, $V_{DDI} = 1.0\text{ V} \pm 0.1\text{ V}/V_{DDI} = 1.2\text{ V} \pm 0.1\text{ V}$, $V_{SS} = 0\text{ V}$, $T_j = -40\text{ }^\circ\text{C}$ to $+125\text{ }^\circ\text{C}$)

Parameter	Symbol	Conditions	Value			Unit
			Min	Typ	Max	
H level output voltage	V_{OH}	3.3 V output $I_{OH} = -100\text{ }\mu\text{A}$	$V_{DDE} - 0.2$	—	V_{DDE}	V
L level output voltage	V_{OL}	3.3 V output $I_{OL} = 100\text{ }\mu\text{A}$	0	—	0.2	V
Input leakage current	I_L	$V_I = 0\text{ V}$ or $V_I = V_{DDE}$	-10	—	+10	μA
Pull-up/Pull-down resistor	R_p	Pull-up $V_{IL} = 0\text{ V}$ / Pull-down $V_{IH} = V_{DDE}$	15	33	70	$\text{k}\Omega$

Note: For LVCMOS 1.8 V and 2.5 V versions, contact the sales representative.

■ DESIGN METHODS

SOCIONEXT Reference Design Flow provides the following functions that help reduce the development time of large scale, high quality LSIs.

- Statistical Static Timing Analysis (SSTA) improves timing convergence.
- Physical Prototyping enables more accurate estimation of highly reliable designs.
- Layout synthesis with optimized timing is realized by Physical Synthesis Tool.
- High accuracy design environment considers drop in power supply voltage, signal noise, delay penalty and crosstalk.
- I/O design environment (power line design, assignment and selection of I/Os, package selection) considers noise.

■ PACKAGES

The CS201 series can use the same packages that were available for the previous series, allowing a smooth transition from previously developed models.

For details of delivery times, contact the sales representative.

- FBGA packages
- PBGA packages
- TEBGA packages
- FC-BGA packages